Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/624,404	CROUCH ET AL.
Examiner	Art Unit
Mark A. Mais	2616

SEARCHED				
Class	Subclass	Date	Examiner	
370	351-360	3/4/2007	МАМ	
	373 384			
	385 395,6			
	401 410			
	426 464			
	465 466			
	467 522			
SAME AS	ABOVE	8/7/2007	MAM	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	.			
	•			

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
See Attached Electronic Search	3/4/2007	МАМ
See Inventorship Search	8/7/2007	МАМ
See Attached Electronic Search [updated]	8/7/2007	МАМ
· .		,